Notice of References Cited Application/Control No. 10/720,280 Examiner Alix Elizabeth Echelmeyer Applicant(s)/Patent Under Reexamination FUKUDA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0121211	06-2004	Asano et al.	429/033
*	В	US-2003/0072980	04-2003	Formanski et al.	429/13
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
- 0	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 02/080294	10-2002	WIPO	Asano et al.	
	0					
	Р					
	Q					
	R					
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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